

**INFORMATION DISCLOSURE STATEMENT
BY APPLICANT**

Date: March 31, 2004

Page 1 of 1

Atty. Dkt. No.	M#	Client Ref.
	0305377	P-0361.010-US
Applicant: NAVARRO y KOREN et al.		
Appln. No.: 10/665,364		
Filing Date: September 22, 2003		
Examiner:		Group Art Unit: 2854

U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
HN	AR	2003/0002043	01/2003	ABDULHALIM et al.			
	BR	5,910,847	06/1999	VAN DER WERF et al.			
HN	CR	5,674,650	10/1997	DIRKSEN et al.			
	DR						
	ER						
	FR						
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	JR						
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	LR						
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	NR						
	OR						
	PR						
	QR						
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FOREIGN PATENT DOCUMENTS

		Document Number	Date MM/YYYY	Country	Inventor Name		Abstract		Readily Available	
							Enclosed	No	Enclose	No
	SR									
	TR									
	UR									
	VR									
	WR									
	XR									

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

	YR									
	ZR									
	AAR									
	BBR									
	CCR									

Examiner	H. Nguyen	Date Considered:	9/5/04
*EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.			



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Date: May 4, 2004 Page 1 of 1

U.S. PATENT DOCUMENTS:

Examiner's Initials*	Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
HN	AR 6,420,791 B1	07/2002	HUANG et al.	1	1	
HN	BR 2002/0158193 A1	10/2002	SEZGINER et al.	1	1	
	CR					
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	ER					
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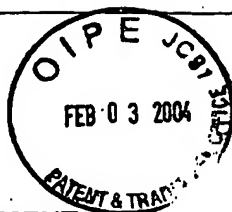
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							Enclosed	No	Enclose	No
	SR									
	TR									
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Date: February 4, 2004

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U.S. PATENT DOCUMENTS

Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
HN	AR	4,037,969	07/1977	FELDMAN et al.			
	BR	4,236,805	04/1982	FELDMAN et al.			
	CR	4,251,160	02/1981	BOUWHUIS et al.			
	DR	4,355,892	10/1982	MAYER et al.			
	ER	4,398,824	08/1983	FELDMAN et al.			
	FR	4,514,858	04/1985	NOVAK			
	GR	4,540,277	09/1985	MAYER et al.			
	HR	4,614,432	09/1986	KUNIYOSHI et al.			
	IR	4,690,529	09/1987	SUGIYAMA et al.			
	JR	4,710,026	12/1987	MAGOME et al.			
	KR	4,748,333	05/1988	MIZUTANI et al.			
	LR	4,778,275	10/1988	VAN DEN BRINK et al.			
	MR	4,814,829	03/1989	KOSUGI et al.			
	NR	4,828,392	05/1989	NOMURA et al.			
	OR	4,857,744	08/1989	KATAOKA et al.			
	PR	4,861,162	08/1989	INA			
	QR	4,870,452	09/1989	TANIMOTO et al.			
	RR	4,952,970	08/1990	SUZUKI et al.			
	SR	5,100,237	03/1992	WITTEKOEK et al.			
	TR	5,114,236	05/1992	MATSUGU et al.			
HN	UR	5,118,953	06/1992	OTA et al.			

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	Document Number	Date MM/YYYY	Country	Inventor Name	English Abstract	Translation Readily Available
					Enclosed	No
HN	VR 11-329914	11/1999	Japan	SAKO TAKASHI	X	X
	WR					
	XR					
	YR					

OTHER (Including in this order Author, Title, Periodical Name, Date, Pertinent Pages, etc.)

HN	ZR	Markle, D. A., "Submicron 1:1 Optical Lithography", Semi-conductor International, pp. 173-142, May 1986.	X		
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	BBR				
	CCR				

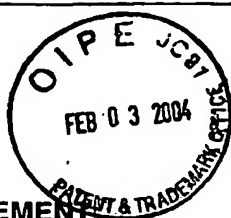
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Examiner's Initials*		Document Number	Date MM/YYYY	Name (Family Name of First Inventor)	Class	Sub Class	Filing Date (if appropriate)
HN	AR	5,144,363	09/1992	WITTEKOEK et al.			
	BR	5,151,754	09/1992	ISHIBASHI et al.			
	CR	5,160,849	11/1992	OTA et al.			
	DR	5,243,195	09/1993	NISHI			
	ER	5,347,356	09/1994	OTA et al.			
	FR	5,418,613	05/1995	MATSUTANI			
	GR	5,477,057	12/1995	ANGELEY et al.			
	HR	5,488,230	01/1996	MIZUTANI et al.			
	IR	5,489,986	02/1996	MAGOME et al.			
	JR	5,543,921	08/1996	UZAWA et al.			
	KR	5,559,601	09/1996	GALLATIN et al.			
	LR	5,596,204	01/1997	IRIE et al.			
	MR	5,801,390	09/1998	SHIRAISHI			
	NR	5,808,910	09/1998	IRIE et al.			
	OR	5,920,376	07/1999	BRUCKSTEIN et al.			
	PR	5,920,378	07/1999	MURAKAMI et al.			
	QR	6,034,378	03/2000	SHIRAISHI			
	RR	6,133,641	10/2000	HAMADA et al.			
	SR	6,233,494 B1	05/2001	AOYAGI			
	TR	6,242,754 B1	06/2001	SHIRAISHI et al.			
HN	UR	6,297,876 B1	10/2001	BORNEBROEK			

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Docket Number: 081468-0305377
Client Reference: P-0361.010-US

PATENT APPLICATION

APPENDIX

Examiner's Initials	First Inventor	Application No.	Filing Date	Enclosed
HN	Van Haren et al.	10/665,360 US 2004/0114143	September 22, 2003	<input checked="" type="checkbox"/> Specification <input checked="" type="checkbox"/> Drawings <input checked="" type="checkbox"/> Other: Papers as filed including any Preliminary Amendment
	Van Bilson	10/665,404	September 22, 2003	<input checked="" type="checkbox"/> Specification <input checked="" type="checkbox"/> Drawings <input checked="" type="checkbox"/> Other: Papers as filed including any Preliminary Amendment
HN	Den Boef et al.	10/665,720 US/20040129900	September 22, 2003	<input checked="" type="checkbox"/> Specification <input checked="" type="checkbox"/> Drawings <input checked="" type="checkbox"/> Other: Papers as filed including any Preliminary Amendment

The Examiner's initials indicates he/she has considered the cited application relative to the subject application.

DO NOT PRINT the above information on the patent which results from the subject application.